

PCIe Gen-5 M.2 Socket 3 Test Adapters

Performance Report



WILDER
TECHNOLOGIES

It's all about integrity

Table of Contents

Pages 2-8. High-Speed Serial Results

- Characterization - Measurement of the CLB and CBB Independent separately using a VNA.
- Mated CLB/CBB – Measurement of the CLB and CBB Independent mated together using a VNA.
- Total Test Channel Loss for Gen 5 and Gen 4.

Pages 9-11. Voltage Rail Results

- Loading – Applying an electronic load to each voltage rail to draw current limits.
- Sequencing – Measuring the start-up delay between voltage rails using an oscilloscope.

Pages 12-14. REFCLK Results (CBB Independent Only)

- Jitter – Measuring the phase jitter of REFCLK using an oscilloscope and a jitter test tool from PCI SIG.
- Characteristics – Measuring the specific aspects of the REFCLK waveform using an oscilloscope.
- SSC – Measure REFCLK down spread SSC using an oscilloscope.

Page 15-17. CMTS Results

- Characteristics – Measuring the noise and frequency of the CTMS signal using an oscilloscope.
- Equalization Presets – Ensuring the CMTS signal triggers each equalization state in an PCIe system by measuring the transmitted compliance preset signals up to PCIe Gen 5.

Page 18-19. PERST Results

- Automatic – Measuring the delay in the PERSTn signal once the 1.8V powers up. The delay should be 100ms.
- Manual – Measuring the delay in the PERSTn signal once the PERST push button is activated. The delay should be 100ms.

High-Speed Serial Results

The high-speed serial measurements of the PCIe Gen5 M.2 adapters use a 4-port (50-ohm) VNA calibrated from 50MHz to 40GHz with 800 points. The measurements are in the form of s-parameters.

The s-parameter measurements are renormalized to 42.5-ohm ports instead of 50-ohm ports. This was done so that the port impedance and adapter impedance match.

In addition, 2.92mm to MMPX adapters and MMPX connectors are included in the s-parameter measurements, but they are then gated out of the return loss due to their 50-ohm impedance.

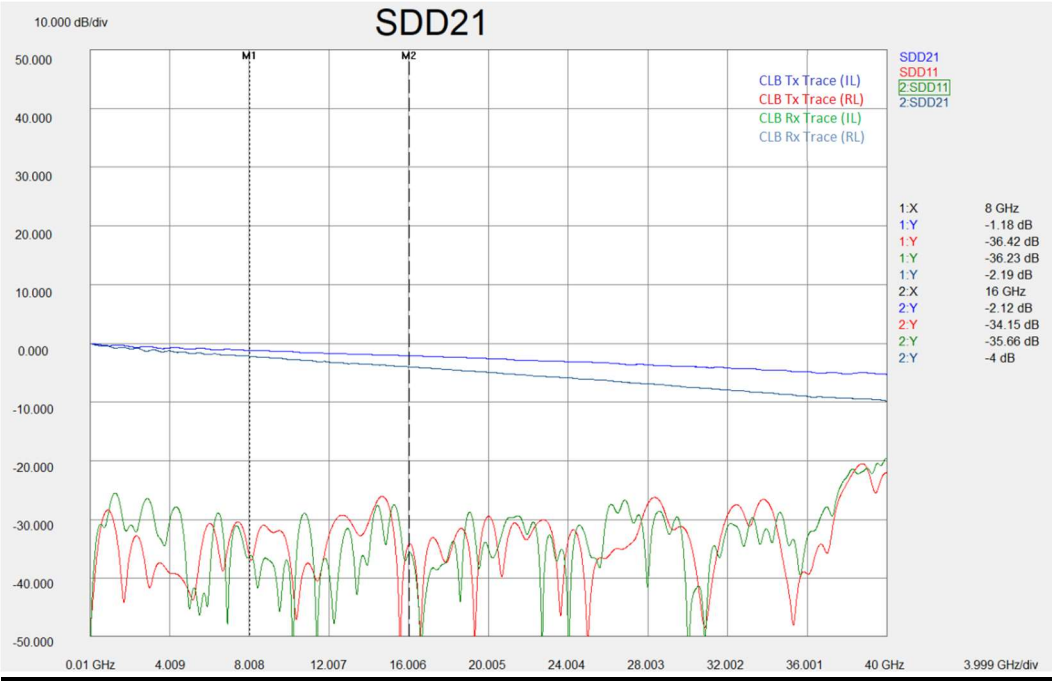
Ultimately, this post-processing makes the s-parameters accurately represent the performance of the high-speed channels of only the M.2 adapters.

Characterization (CLB and CBB Independent Only):

To characterize the real high-speed channels of the adapters only (no connector), the replica channels must be used. These replica channels include MMPX connector lead-in for what would be the M.2 connector side of the high-speed channels. This MMPX connector lead-in that is part of the S-parameter measurement must then be de-embedded to represent the real high-speed channels.

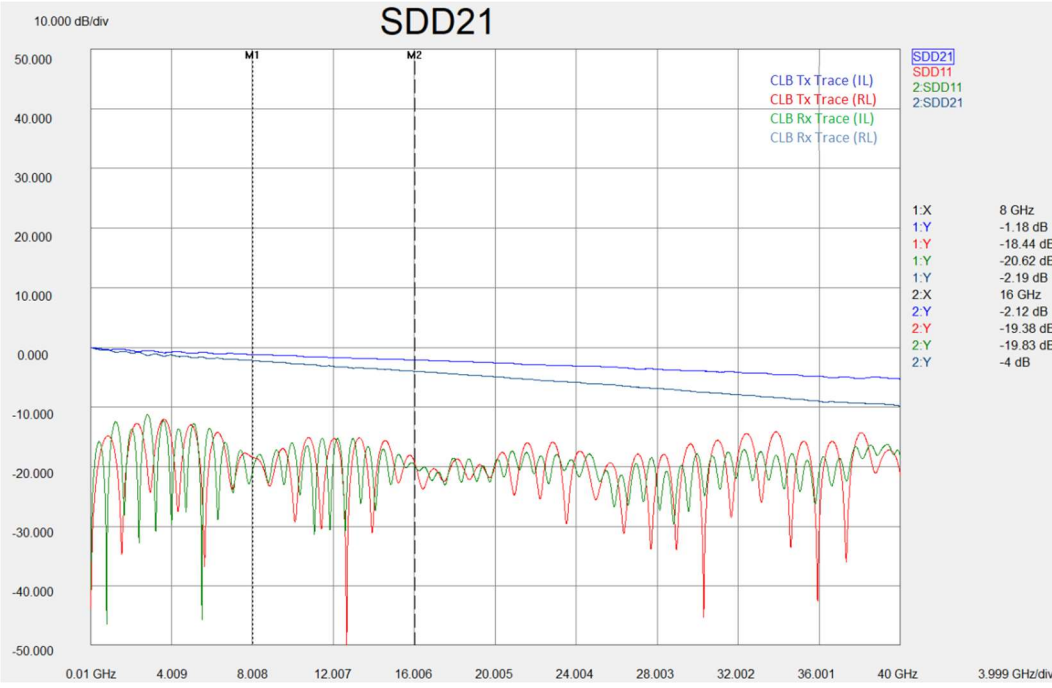
M.2 Test Adapters Performance Report

Figure 1: CLB Only Characterization



Corrected return loss maintains below 20dB.

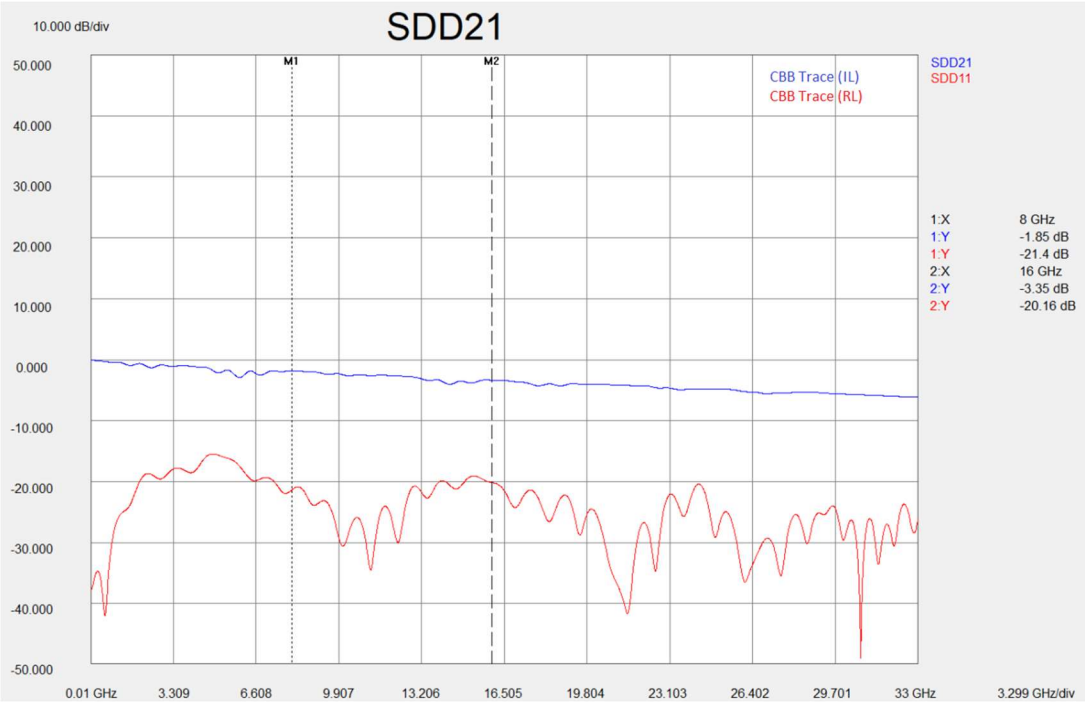
Figure 2: CLB Only Characterization, No Correction or Gating



Uncorrected return loss maintains below 10dB.

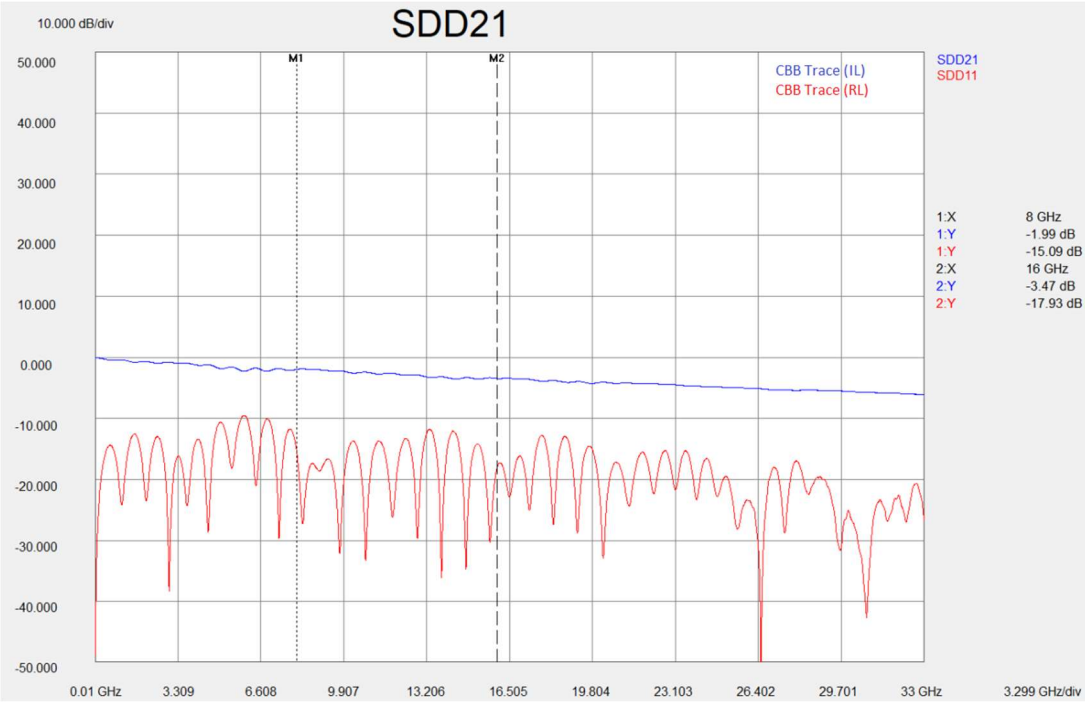
M.2 Test Adapters Performance Report

Figure 3: CBB Only Characterization



Corrected return loss maintains below 15dB.

Figure 4: CBB Only Characterization, No Correction or Gating

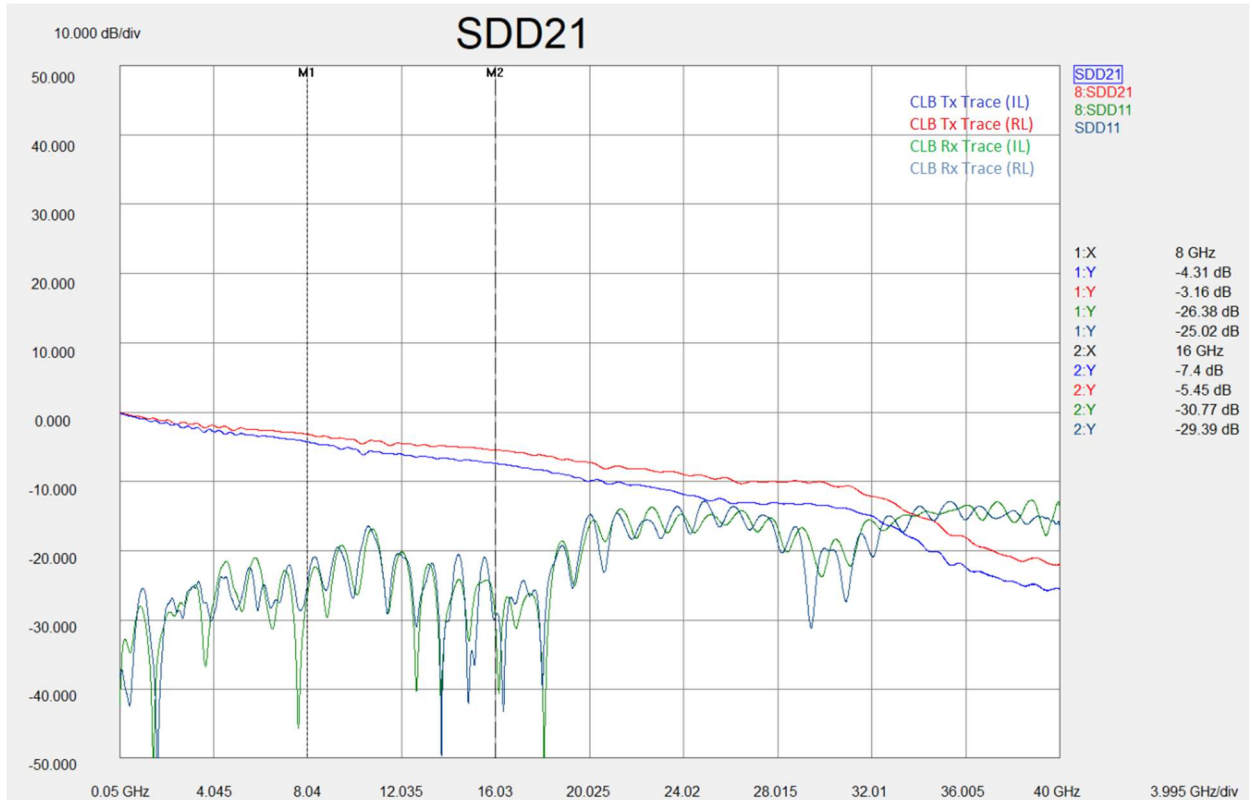


Corrected return loss maintains below 10dB.

Mated CLB/CBB (CLB and CBB Independent Only):

These s-parameter measurements are made when the CLB and CBB are mated. The M.2 connector is included in the measurement. The MMPX connectors and 2.92mm to MMPX adapters are included in the s-parameter, but then are gated out.

Figure 5: CLB and CBB Mated Insertion and Return Loss



Return Loss is near or below -10dB from 10MHz to 40GHz. There are no significant resonances.

M.2 Test Adapters Performance Report

Figure 6: CLB and CBB Mated Insertion and Return Loss, No Correction or Gating

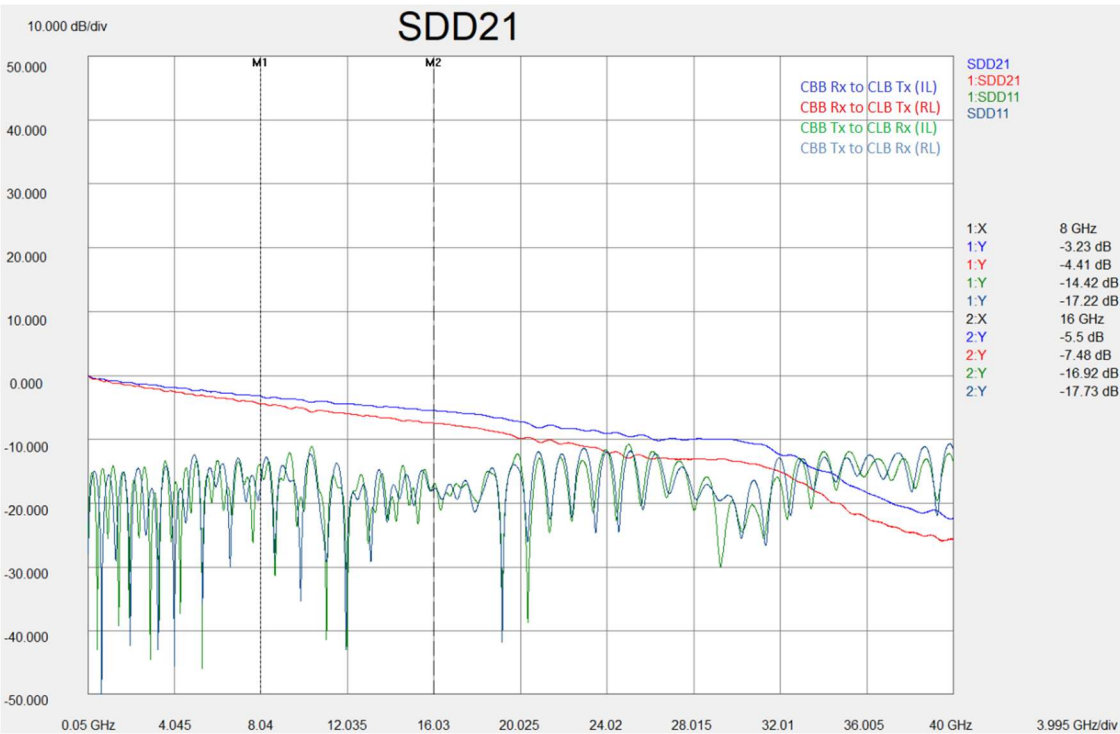
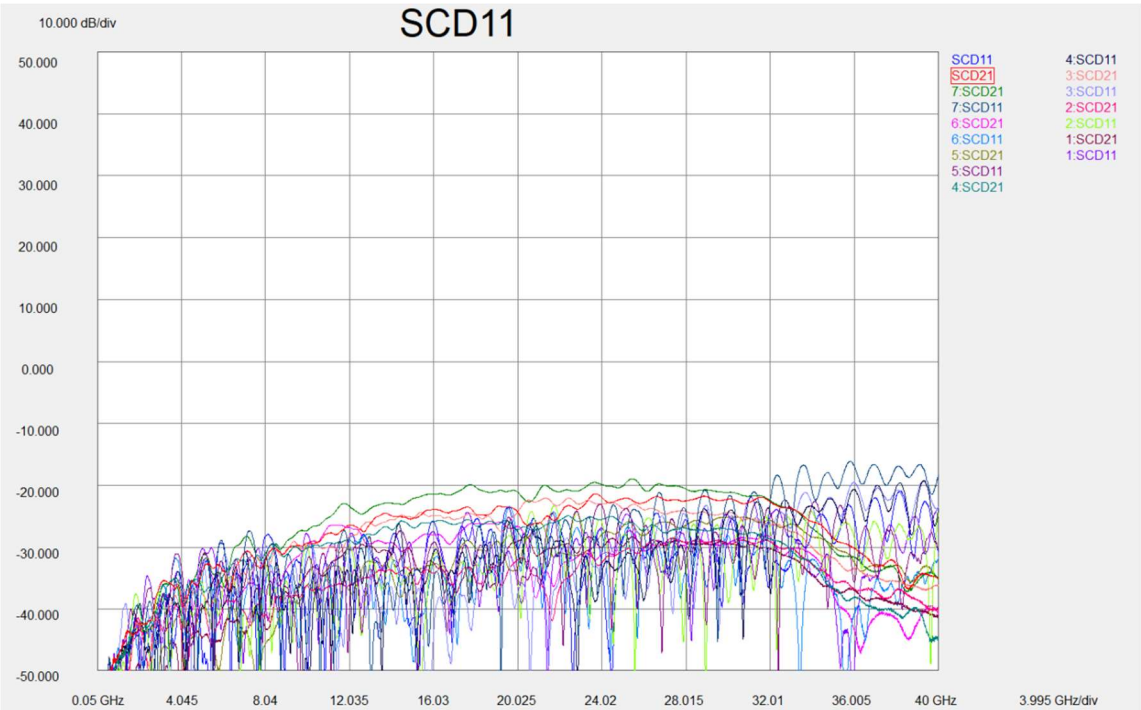


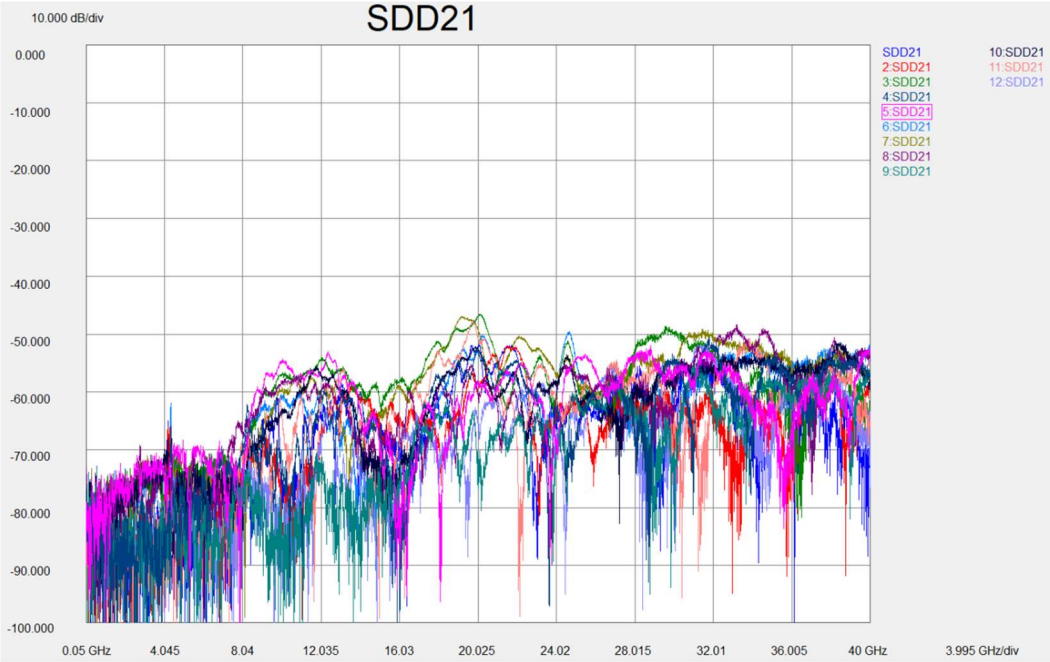
Figure 7: CLB and CBB Mated Conversion Loss



Maintains below -20dB for all frequencies except after 32GHz.

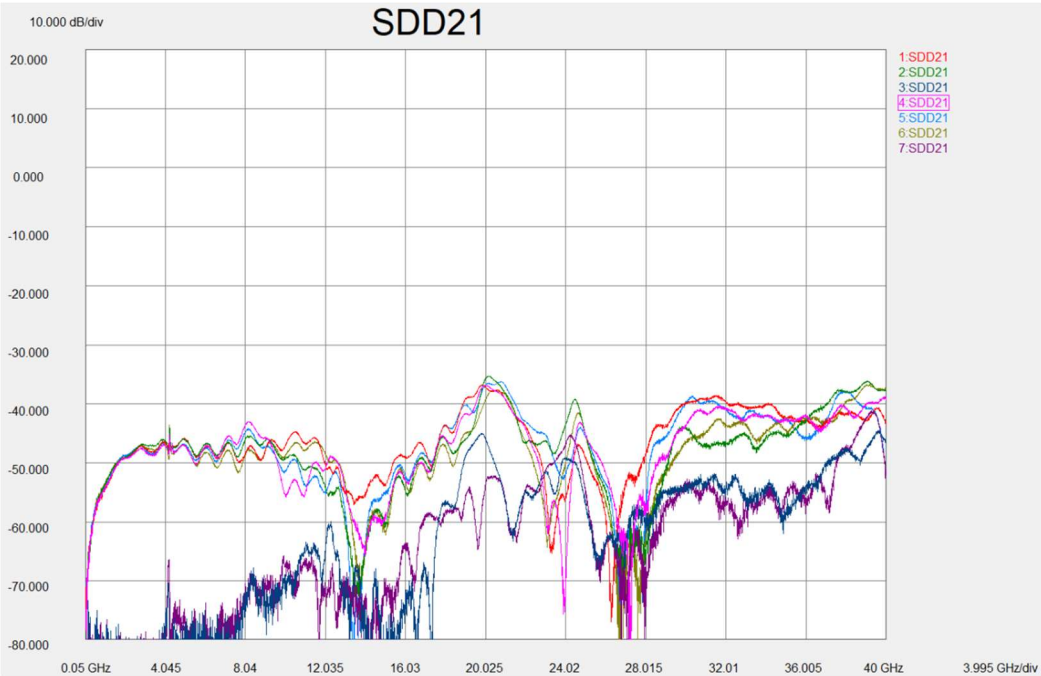
M.2 Test Adapters Performance Report

Figure 8: CLB and CBB Mated FEXT



Maintains at or below -44dB for all frequencies.

Figure 9: CLB and CBB Mated NEXT



Maintains at or below -35dB for all frequencies.

Fixture Test Channel Setup:

Figure 10: Total Test Channel Loss for Gen5

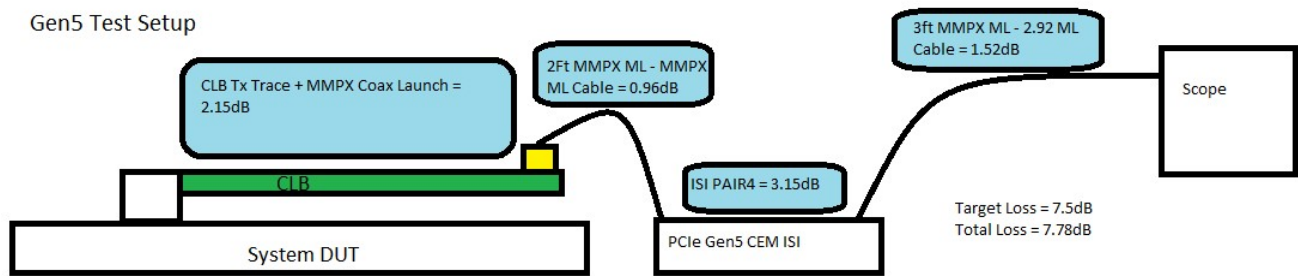


Figure 11: Total Test Channel Loss for Gen4

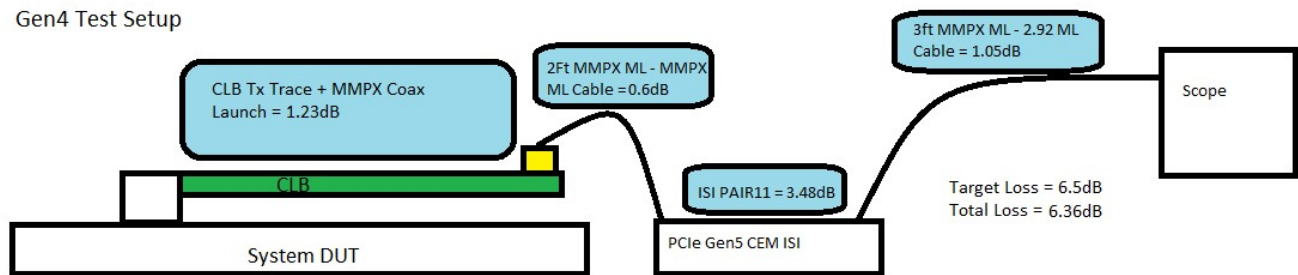


Figure 12: System Rx Calibration Example

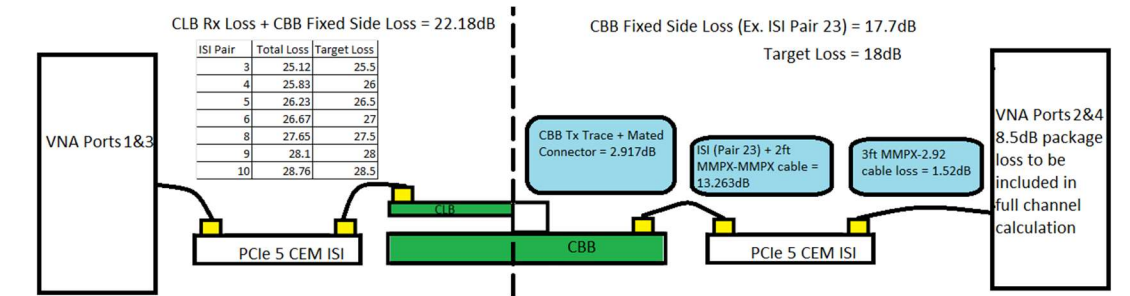
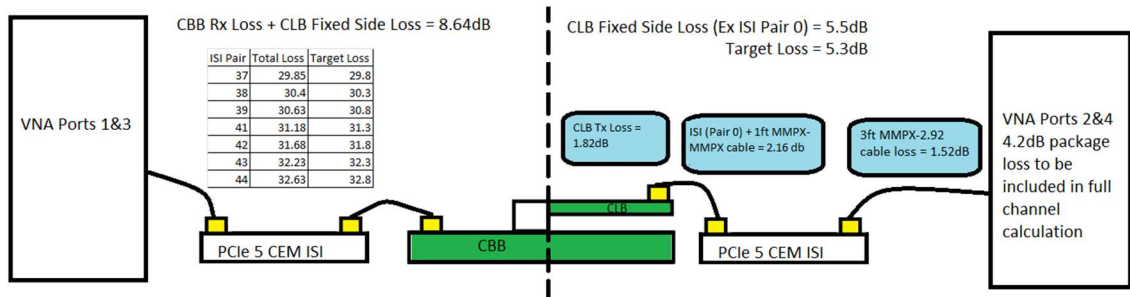


Figure 13: AIC Rx Calibration Example



Voltage Rail Results

Loading:

An electronic load is connected to each voltage rail one at a time with the load according to the peak current values in the figure from the M.2 specification shown below.

Figure 14: Table 4-23 from PCI Express M.2 Specification

Table 4-23. Power Rating Table for M.2 Add-in Cards

Key	Power Rail	Voltage Tolerance	Current Consumption Limit	
			Peak (Note 1) mA Max Avg @ 100 μ s	Normal (Note 2) mA Max Avg @ 1 s
A	3.3 V	$\pm 5\%$	2000	
B	3.3 V	$\pm 5\%$	5000 (Note 6)	2500 (Note 5)
B	V _{BAT} (Note 3)	3.135 V to 4.4 V	2500	
C	3.3 V	$\pm 5\%$	2500	
C	V _{BAT}	3.135 V to 4.4 V	2500	
C	VIO 1.8 V	$\pm 5.55\%$ (Note 4)	70	
D	RFU	RFU	RFU	RFU
E	3.3 V	$\pm 5\%$	2000	
F	RFU	RFU	RFU	RFU
G	N/A	N/A	N/A	N/A
H	RFU	RFU	RFU	RFU
J	RFU	RFU	RFU	RFU
K	RFU	RFU	RFU	RFU
L	RFU	RFU	RFU	RFU
M	3.3 V	$\pm 5\%$	7000 (Note 6)	3500 (Note 5)
M	VIO 1.8 V	$\pm 5.55\%$ (Note 4)	70	

Notes:

1. Peak is the maximum highest averaged current value over any 100 μ s period
2. Normal is the maximum highest averaged current value over any 1 s period
3. Power Rail connection alternative for WWAN specific Adapters only. Not supported by other Socket 2 Adapter types such as SSDs
4. 1.7 V to 1.9 V Range
5. Normal currents assume sufficient power dissipation capability by the Platform. This capability is outside the scope of this specification. The maximum power of device may be controlled through function specific capabilities (e.g., for SSDs see NVMe).
6. The peak current's duty cycle shall ensure that the normal current is not violated.

M.2 Test Adapters Performance Report

Figure 15: Electronic Load Results for the 3.3V Rail



Figure 16: Electronic Load Results for the 1.8V Rail



The voltage is within the tolerance at the CBB test points. The voltage rails are successfully loaded with no unexpected voltage drops and no overheating.

Sequencing:

In this section, the 1.8V rail start-up time is compared against the 3.3V start-up time.

This comparison is accomplished using an oscilloscope with header connection probes. They connect at the test points near the voltage converters.

Figure 17: Voltage Rail Sequence Test Measurement



Sequence Delay (1.8V Rail) = 9.711ms

M.2 states that the 3.3V rail needs to meet at least 300mv before the 1.8v rail is switched on. Additionally, the 3.3v rail needs to remain at least 200mv higher than the 1.8V rail. The 3.3V rail fully powers for about 10ms before the 1.8V rail powers on meeting the power on requirements.

REFCLK Results (CBB Independent Only)

A differential probe along with 2.92mm to MMPX cables were used to measure the REFCLK waveform generated by the CBB independent adapter on the oscilloscope.

This waveform was then saved to a .bin file and imported into the Clock Jitter Tool.

PCI-SIG website provided a link to this test tool.

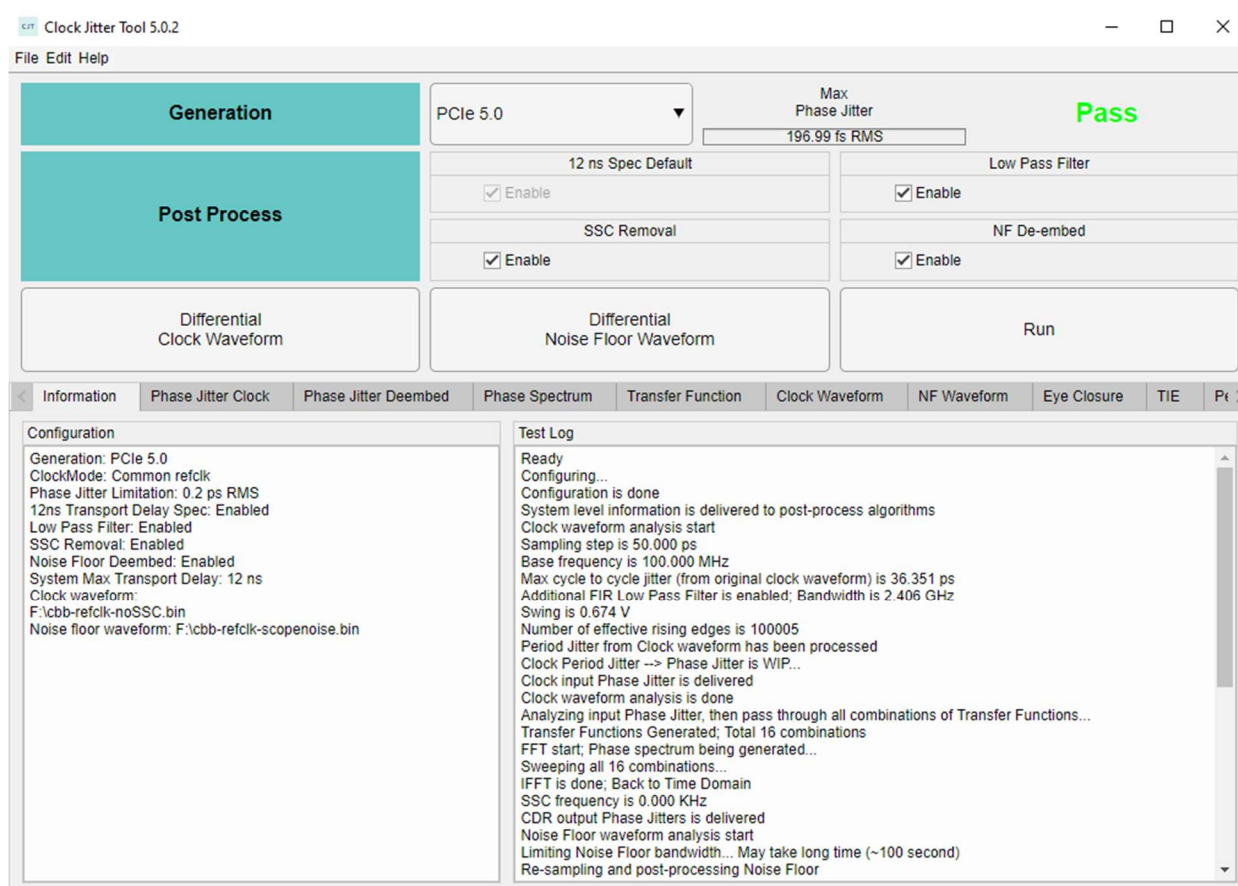
Jitter:

REKCLK passes phase jitter requirements.

The max phase jitter shows 196.99 fs RMS which is below 200fs RMS limit in the PCIe specification.

Note: Real Time Scope noise has been removed during post processing.

Figure 18: Clock Jitter Tool Results Window



M.2 Test Adapters Performance Report

Characteristics:

Period: 9.9985754ns, Pass

V max/mind: +/-356mV, Pass

Rise time: 647ps, Rise Time Rate: 0.88V/ns, Pass

Fall time: 653ps, Fall Time Rate: 0.87V/ns, Pass

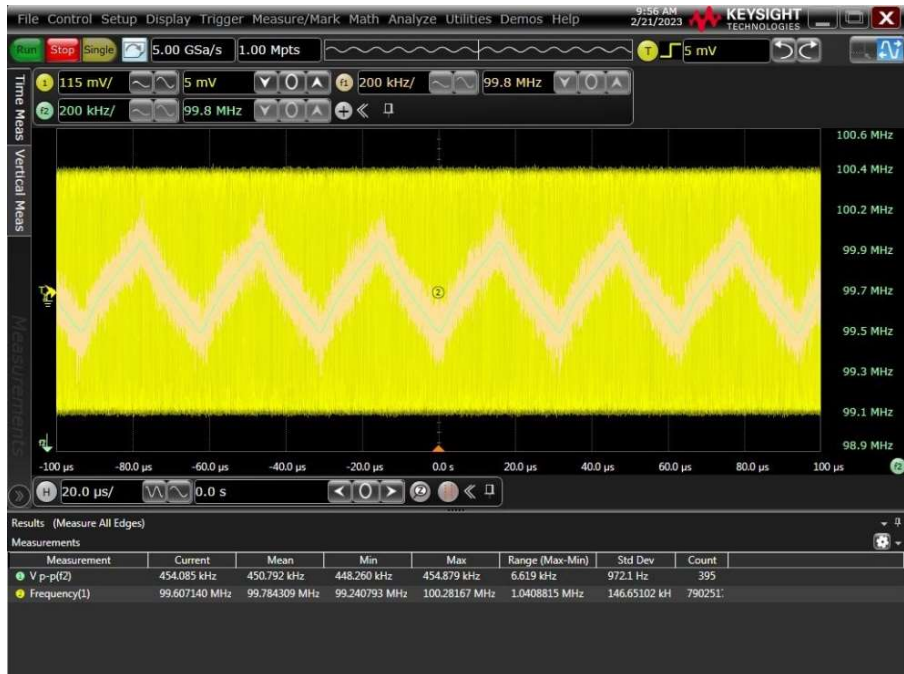
Figure 19: REFCLK Characteristics on Real Time Oscilloscope



M.2 Test Adapters Performance Report

SSC:

Figure 20: REFCLK with SSC set at -0.5% down spreading



SSC Setting: -0.5%, Actual -0.45%

Figure 21: REFCLK with SSC set at -0.5% down spreading



SSC Setting: -0.25%, Actual -0.27%

CMTS (Compliance Mode Toggle Signal) Results

A differential probe along with 2.92mm to MMPX cables were used to measure the CMTS waveform and equalization presets on the oscilloscope. CMTS push button was used to activate the CMTS.

Characteristics:

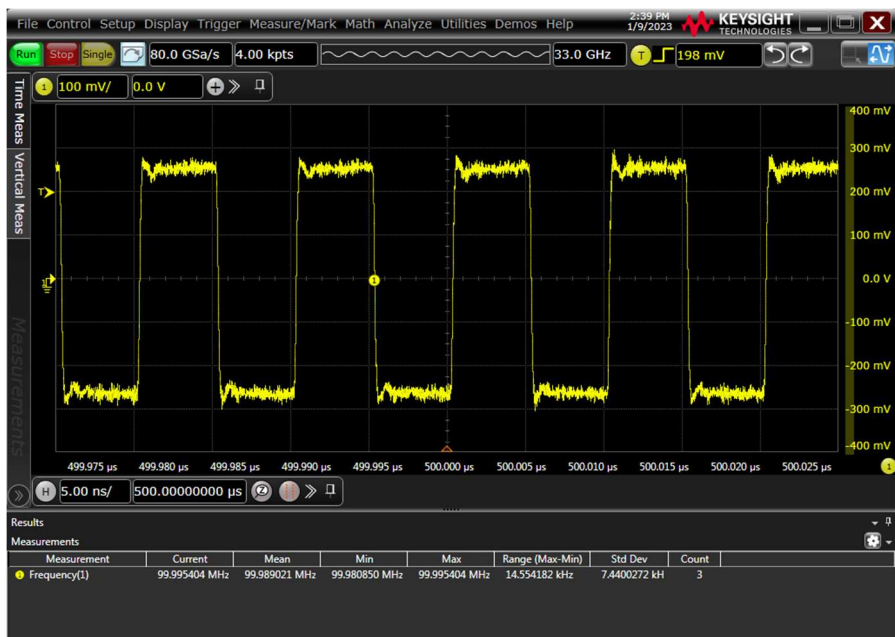
Figure 22: 40mV Noise Test of CMTS



The noise is under +/-40mV before and after the trigger of CMTS.

M.2 Test Adapters Performance Report

Figure 23: CMTS Frequency



The CMTS frequency shows a mean of 99.989021MHz.

Figure 24: CMTS Pulse Length



The CMTS time length is 1ms.

These characteristics are adequate for toggling transmitter equalization presets.

M.2 Test Adapters Performance Report

DUT Compliance toggling:

The CMTS signal successfully toggles compliance toggle patterns in an M.2 PCIe Gen 5 system and those measurements are shown below.

Figure 25: Measured Compliance Patterns on GEN5 System DUT (32GT/s PCIe 5.0 PRESET 0)

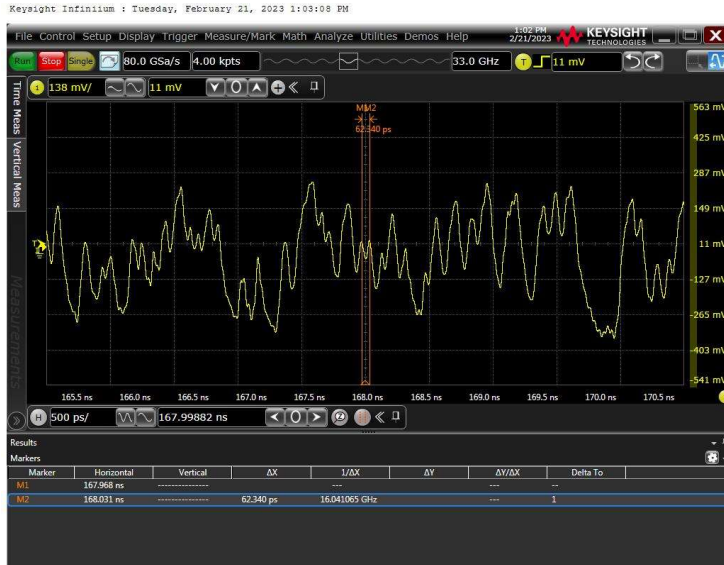


Figure 26: Measured Compliance Patterns on GEN3 AIC DUT (8.0GT/s PCIe 3.0 Preset 0)



The M.2 Test Adapters support PCI Express systems that use PCIe Gen 5. The test measurements for Gen5 AIC DUT are not shown in this report.

PERST Results

This PERST test is accomplished using an oscilloscope with header connection probes. They connect at the 1.8V rail test point and the PERSTn trace on the CBB.

The voltage rail and PERSTn transition can be seen on the oscilloscope on CBB start-up. The PERSTn transition can also be seen when the PERST button is pressed on the CBB. The delay between these transitions is then measured on the oscilloscope.

Automatic (Start-Up):

Designed delay = 100ms

Measured delay = 103.58ms

The figure below shows the delay between the 1.8V rail and PERSTn signal.

Figure 27: Delay Measurement between 1.8V rail start-up and PERSTn Rise on Real-Time Oscilloscope



Manual (Push-Button Activated):

Designed delay = 100ms

Measured delay = 103.84ms

M.2 Test Adapters Performance Report

The figure below shows the delay between PERST button push and PERSTn signal.

Figure 28: Delay Measurement After PERST Button Press on Real-Time Oscilloscope





WILDER
TECHNOLOGIES

It's all about integrity

Wilder Technologies, LLC
11201 NE 9th St.
Vancouver WA, 98684
Phone: 360-859-3041
Fax: 360-859-3105
www.wilder-tech.com

©2024 Wilder Technologies, LLC
Document No. 910-0077-100 Rev. B
Initial Release: 2/22/23
Updated: 2/29/24